Bayesian *C*-optimal life testing plans under progressive type-I interval censoring scheme

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Highlights

Optimal <u>Bayesian</u> life tests plans are presented under Progressive Type-Interval <u>Censoring Scheme</u>.

Bayesian *C*-optimal <u>design criterion</u> is used.

An algorithm is presented for log-location-scale family of distributions.

A comparative study is provided for Weibull and log-normal lifetime distributions.

Sampling variations are visualized through MCMC methods.

Abstract

This work considers optimal planning of progressive type-I interval censoring schemes for log-location-scale family of distributions. Optimum schemes are obtained by using a Bayesian *C*-optimality design criterion. The *C*-optimality criterion is formed to attain precision in estimating a particular lifetime quantile. An algorithm is proposed to obtain the optimal censoring schemes. Optimal schemes are obtained under two different scenarios for the Weibull and log-normal models, which are two popular special cases of log-location-scale family of distributions. A sensitivity analysis is conducted to study the effect of various prior inputs on the optimal censoring schemes. Furthermore, a simulation study is undertaken to illustrate the sampling variations resulting from the optimal censoring schemes.